

Application/Control No.	Applicant(s)/Patent und Reexamination	der
10/718,599	TAKEZAWA ET AL.	
Examiner	Art Unit	
Janis L. Dote	1756	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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